Supporting Information for

## Highly efficient hydrogen evolution of platinum via tuning the interfacial dissolved-gas concentration

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## **Experimental Section**

**Chemicals and materials.** Perchloric acid (HClO<sub>4</sub>, 70%), sodium perchlorate (NaClO<sub>4</sub>, 98%) and calcium chloride (CaCl<sub>2</sub>, 99%) were purchased from Sigma-Aldrich. Potassium perfluorooctanesulfonate (PFOS) was received from Matrix Scientific. Platinum wires (Pt, 25 and 50  $\mu$ m diameter, 99.95%) were obtained from Alfa Aesar. Glass capillaries were received from Dagan Corporation. Ultrapure water (Milli-Q, 18.2 MΩ) was used in all experiments.

**Fabrication of Pt nanoelectrode.** The Pt nanoelectrodes were fabricated through two steps based on a previous method.<sup>1</sup> First, the Pt tips were prepared by electrochemically etching of Pt wire in 15 wt% CaCl<sub>2</sub> solution using a 100 Hz sinusoidal wave with an amplitude of 4.0 V. After sharpening, the Pt tips were washed by water. Second, the as-prepared Pt tips were thermal sealed in a glass capillary. Then the sealed tip was polished on a silicon carbide polishing sandpaper until a Pt nanodisk was exposed, which was monitored by using an electronic feedback circuit. The radius (*a*) of obtained nanoelectrode was calculated through testing the steady-state diffusion-limited current (*i<sub>d</sub>*) associated with the reduction of proton in 0.1 M HClO<sub>4</sub> solution. *i<sub>d</sub>* = 4*nFDC*<sup>\*</sup>*a*, where *n* is the number of electrons transferred per molecule, *F* is Faraday constant, *D* is the diffusion coefficient of proton (7.8 × 10<sup>-5</sup> cm<sup>2</sup>/s),<sup>2</sup> and *C*<sup>\*</sup> is the bulk concentration of proton.

**Electrochemical measurements.** The electrochemical measurements were performed on a CHI 760E electrochemical workstation. For the measurements of Pt nanoelectrode, an Ag/AgCl was used as the counter/reference electrodes. The radius test was carried out via voltammetry in 0.1 M HClO<sub>4</sub> solution at a sweep rate of 100 mV/s with 0.1 M NaClO<sub>4</sub> added as supporting electrolyte. The nanobubble tests were performed by the voltammograms in 0.5 M HClO<sub>4</sub> solution at a sweep rate of 100 mV/s. For HER measurements, a typical three-electrode system was used. A Pt rotating disk electrode (Pine Instruments, diameter of 5 mm) was used as the working electrode with a graphite rod as the counter electrode and an Ag/AgCl as the reference electrode. All the potentials were calibrated with respect to the reversible hydrogen electrode (RHE),<sup>3</sup> and in 0.5 M HClO<sub>4</sub> solution with all the PFOS concentrations,  $E_{RHE} = E_{Ag/AgCl} + 0.205$  V. The cyclic voltammetry (CV) measurements were recorded in 0.5 M HClO<sub>4</sub> solution at a sweep rate of 50 mV/s under a flow of N<sub>2</sub>. The polarization curves were obtained in N<sub>2</sub>-saturated 0.5 M HClO<sub>4</sub> electrolyte at a rotation rate of 1,600 rpm and a scan rate of 2 mV/s. The galvanostatic measurements were carried out in an N<sub>2</sub>-saturated 0.5 M HClO<sub>4</sub> solution under a current density of 10 mA cm<sup>-2</sup>.

**Characterizations.** SEM images were taken using a JSM-7600 field-emission scanning electron microscope operated at 15 kV. Digital images were collected on an optical microscope with a high-speed charge coupled device (OMAX). Electrical continuity during nanoelectrode polishing was measured using a high-input impedance (MOSFET)-based circuit.

## References

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- 2 Q. J. Chen, L. Luo, *Langmuir*, 2018, **34**, 4554.
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Figure S1. (A) SEM image of a Pt tip fabricated by electrochemical etching. (B) Corresponding SEM image of Pt tip with high magnification.



Figure S2. Steady-state voltammetric response of Pt nanoelectrode recorded at a sweep rate of 100 mV/s.



Figure S3. The blow-ups of H<sub>upd</sub> desorption peaks for (A) pure Pt and (B) PFOS-Pt at different galvanostatic test time.



Figure S4. Normalized ECSA for PFOS-Pt and pure Pt before and after long-term galvanostatic test.



Figure S5. Bubble generation on the electrode (A) before and (B) after HER test without applying a rotating speed.



Figure S6. *iR*-corrected polarization curves of (A) Pt mesh and (B) Au disk electrode with PFOS modulation.



Figure S7. Chronopotentiometric measurements for PFOS-Pt and pure Pt at the cathodic current density of 10 mA cm<sup>-2</sup>.



**Figure S8.** (A) *iR*-corrected polarization curves of PFOS-Pt with different PFOS concentrations in  $N_2$ -saturated 0.5 M HClO<sub>4</sub> solution. (B) Tafel plots of PFOS-Pt with different PFOS concentrations.



**Figure S9.** (A) *iR*-corrected polarization curves of PFOS-Pt with high PFOS concentrations. (B) Comparison of current densities of PFOS-Pt with high PFOS concentrations.



Figure S10. Comparison of the blow-ups of  $H_{upd}$  desorption peaks for 10<sup>-5</sup> PFOS-Pt before and after HER test.